Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/713,877	CHURCHILL ET AL.	
Examiner	Art Unit	
Tod M. Wang	2611	

	SEARCHED					
Class	Subclass	Date	Examiner			
375	354, 355	11/5/2007	TW			
375	326, 327	11/5/2007	TW			
375	376	11/5/2007	TW			
		-				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	326, 327	11/5/2007	TW	
375	354, 355	11/5/2007	TW	
375	376	11/5/2007	TW	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	11/5/2007	TW		
ODP- searched and reviewed.	11/5/2007	TW		
Inventor search -(Russell with Churchill) or (Vincent with Figueroa)	11/5/2007	TW		
IEEExplor - Advance search - data recover* and PLL and (polyphase or multiphase or (multiple adj1 phase))	11/5/2007	TW		
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